

Amendment to the Claims

Please cancel claims 37-40. Following is a complete listing of claims, as amended:

1. (Previously presented) A processing container for electrochemically processing a microelectronic workpiece comprising:
 - a principal fluid flow chamber;
 - a plurality of concentric anodes disposed in the principal fluid flow chamber, the concentric anodes being independently coupled to a power supply; and
 - a controller operatively coupled to the concentric anodes, the controller having a computer operable medium including instructions that cause unique electric currents to be applied concurrently to different concentric anodes while the workpiece is under process.
2. (Previously presented) The processing container of claim 1 wherein the plurality of concentric anodes are contained within dielectric compartments.
3. (Previously presented) The processing container of claim 2 wherein the principal fluid flow chamber is defined by a curved sidewall.
4. (Previously presented) The processing container of claim 1, further comprising a plurality of dielectric anode compartments having lateral projections at an upper end of the compartments, the concentric anodes being housed in corresponding compartments, and the lateral projections shielding the workpiece from the concentric anodes to define a plurality of concentric virtual anodes.

5. (Previously presented) The processing container of claim 1, further comprising a virtual anode including:

an anode chamber housing having a processing fluid inlet and a processing fluid outlet, the processing fluid outlet being disposed in close proximity to the microelectronic workpiece under process; and
at least one conductive anode element disposed in the anode chamber housing.

6. (Original) The processing container of claim 4 wherein the at least one conductive anode element is formed from an inert material.

7. (Original) The processing container of claim 1 and further comprising a plurality of nozzles disposed to provide a flow of the electrochemical processing fluid to the principal fluid flow chamber, the plurality of nozzles being arranged and directed to provide vertical and radial fluid flow components that combine to generate a substantially uniform normal flow component radially across the at least one surface of the workpiece.

8. (Original) The processing container of claim 1 wherein the principal fluid flow chamber is defined at an upper portion thereof by an angled wall, the angled wall supporting one or more of the plurality of concentric anodes.

9. (Original) The processing container of claim 1 wherein the principal fluid flow chamber further comprises an inlet disposed at a lower portion thereof that is configured to provide a Venturi effect that facilitates recirculation of processing fluid flow in a lower portion of the principal fluid flow chamber.

10. (Previously presented) The processing container of claim 1 wherein the controller further comprises a current optimization subsystem for selecting the currents delivered through the concentric anodes by the controller.

11. (Original) The processing container of claim 10, further comprising a memory containing a Jacobian sensitivity matrix reflecting characteristics of the principal fluid flow chamber used by the current optimization subsystem in selecting the currents delivered through the concentric anodes by the controller.

12. (Original) The processing container of claim 1, further comprising a pump for circulating processing fluid within the principal flow chamber.

13. (Original) The processing container of claim 1 wherein the fluid flow chamber is adapted to contain an electrolyte solution for electroplating the microelectronic workpiece.

14. (Previously presented) The processing container of claim 13 wherein the current delivered by the controller to each anode is selected to produce a more uniform layer of electroplated material on the microelectronic workpiece under process than was produced on an earlier-processed microelectronic workpiece.

15.-22. (Canceled)

23. (Original) A reactor for electrochemically processing a microelectronic workpiece comprising:

a principal fluid flow chamber;

a plurality of electrodes disposed in the principal fluid flow chamber;

a workpiece holder positioned to hold at least one surface of the microelectronic workpiece in contact with an electrochemical processing fluid in the principal fluid flow chamber at least during electrochemical processing of the microelectronic workpiece;

one or more electrical contacts connected to electrically contact the at least one surface of the microelectronic workpiece;

an electrical power supply connected to the one or more electrical contacts and to the plurality of electrodes, at least two of the plurality of electrodes being independently connected to the electrical power supply to facilitate independent supply of power thereto;

a control system connected to the electrical power supply to control at least one electrical power parameter respectively associated with each of the independently connected electrodes, the control system setting the at least one electrical power parameter for a given one of the independently connected electrodes based on one or more user input parameters and a plurality of predetermined sensitivity values, the predetermined sensitivity values corresponding to process perturbations resulting from perturbations of the electrical power parameter for the given one of the independently connected electrodes.

24. (Original) A reactor as claimed in claim 23 wherein the at least one electrical parameter is electrical current.

25. (Original) A reactor as claimed in claim 23 wherein the sensitivity values are logically arranged within the control system as one or more Jacobian matrices.

26. (Original) A reactor as claimed in claim 23 wherein the at least one user input parameter comprises the thickness of a film that is to be electrochemically deposited on the at least one surface of the microelectronic workpiece.

27. (Original) A reactor as claimed in claim 23 wherein at least two of the independently connected electrodes are disposed at different effective distances from the surface of the microelectronic workpiece.

28. (Original) A reactor as claimed in claim 23 wherein the independently connected electrodes are arranged concentrically with respect to one another.

29. (Original) A reactor as claimed in claim 23 wherein the independently connected electrodes are disposed at the same effective distance from the at least one surface of the microelectronic workpiece.

30. (Original) A reactor as claimed in claim 29 wherein the independently connected electrodes are arranged concentrically with respect to one another.

31. (Original) A reactor as claimed in claim 27 wherein the independently connected electrodes are arranged concentrically with respect to one another.

32. (Original) A reactor as claimed in claim 31 wherein the independently connected electrodes are arranged at increasing distances from the at least one surface of the microelectronic workpiece from an outermost one of the plurality of concentric anodes to an innermost one of the independently connected electrodes.

33. (Original) A reactor as claimed in claim 23 wherein one or more of the independently connected electrodes is a virtual electrode.

34. (Original) A reactor as claimed in claim 33 wherein the virtual electrode comprises:

an electrode chamber housing having a processing fluid inlet and a processing fluid outlet, the processing fluid outlet being disposed in close proximity to the microelectronic workpiece under process;

at least one conductive electrode element disposed in the electrode chamber housing.

35. (Original) A processing container as claimed in claim 34 wherein the at least one conductive electrode element is formed from an inert material.

36. (Original) A processing container as claimed in claim 23 and further comprising a plurality of nozzles disposed to provide a flow of the electrochemical processing fluid to the principal fluid flow chamber, the plurality of nozzles being arranged and directed to provide vertical and radial fluid flow components that combine to generate a substantially uniform normal flow component radially across the at least one surface of the workpiece.

37-63. (Canceled)